# PHIMECA

... solutions for robust engineering

## Rare events probability estimation

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'HPC and Uncertainty Treatment – Examples with Open TURNS and Uranie'

EDF – Phimeca – Airbus Group – IMACS – CEA

PRACE Advanced Training Center - May, 10-12 2021









## Outline

- Problem definition
- Brute-force estimation using Monte Carlo sampling
- Most-probable-failure-point(s)-based methods

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## Problem definition

#### Given

a random vector with known probability distribution:

$$X \sim F_X$$

modelling the uncertainty attached to a component of interest.

a performance model to define its state :

$$g(x)$$
, with  $\begin{cases} g(x) \leq 0 \Rightarrow system\ failure \\ otherwise, system\ safe \end{cases}$ 

### Objective

To quantify the component safety level with a failure probability.



Failure probability is subjective, condinnned by assumptions/choices (Fx, model, etc.)

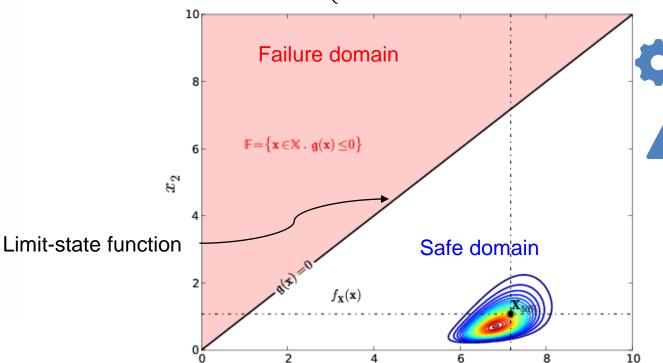


#### Input

• Ex : Resistance vs Stress model:

$$g(r,s) = r - s \text{ with } \begin{cases} R \sim \mathcal{LN}(\lambda_R, \zeta_R) \\ S \sim \mathcal{LN}(\lambda_S, \zeta_S) \end{cases}$$

$$Correlation \text{ by a normal copula } \rho_0 = 0,525$$



 $x_1$ 

 $p_f = \mathbb{P}[g(X) \le 0]$  $p_f = \mathbb{P}[X \in \mathbb{F}]$ 



 $p_f$  is often small !

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## Problem definition

#### Definitions for the failure probability

The failure probability is essentially defined as the *value of the CDF of the safety* margin  $G \equiv g(X)$  at point 0.

$$p_f = \mathbb{P}[g(X \le 0)] = F_G(0) = \int_{-\infty}^0 f_G(t) dt$$

It also rewrites as the sum of X's PDF over the failure domain  $\mathbb{F}$ :

$$p_f = \int_{\mathbb{F} = \{x \in \mathbb{X} : g(x) \le 0\}} f_X(x) dx$$

It eventually rewrites as the expectation of the *failure indicator function*  $\mathbb{I}_{\mathbb{F}}$  over the support X of the input probability distribution:

$$p_f = \int_{\mathbb{X}} \mathbb{I}_{\mathbb{F}}(\mathbf{x}) f_{\mathbf{X}}(\mathbf{x}) d\mathbf{x} = \mathbb{E}[\mathbb{I}_{\mathbb{F}}(\mathbf{X})]$$



## Problem definition

#### **Premise**

- $G \equiv g(X)$ 's distribution is *rarely known* (except for linear combinations of independent r.v. or univariate composite distributions)
- Numerical integration techniques (e.g. quadrature rules) are not suitable for integrating indicator functions (their precision is often less than the probability's order of magnitude).

#### Dedicated methods

- Brute-force estimation using (intensive) Monte Carlo sampling
- Approximation methods
- Advanced, reduced variance, Monte Carlo sampling methods (not covered in this tutorial)
- Surrogate-model-based methods (not covered in this tutorial)



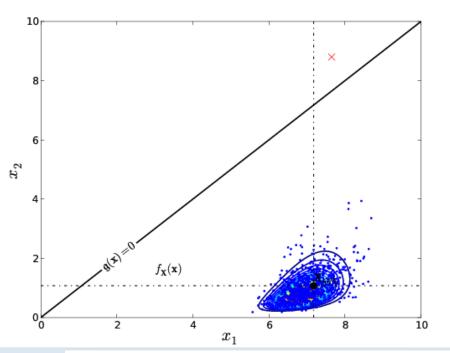
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### Principle

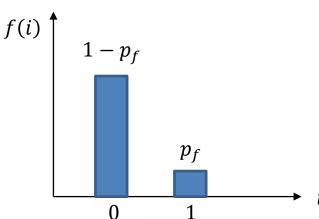
• The crude Monte Carlo estimator of  $p_f$  is the empirical average of the Bernoulli failure experiment:

$$\widehat{P}_{f,\text{MCS}} = \frac{1}{N} \sum_{i=1}^{N} \mathbb{I}_{\mathbb{F}} (X^{(i)})$$



where:

$$\mathbb{I}_{\mathbb{F}}(X) \sim \mathcal{B}\mathrm{er}\big(p_f\big)$$



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## Brute-force Monte Carlo estimation

#### Convergence

According to the *central limit theorem* (CLT), this estimator is unbiased and converges as follows:

$$\widehat{P}_{f, ext{MCS}} \mathop{\sim}_{N o \infty} \mathcal{N} \left( p_f, \sqrt{\frac{p_f(1-p_f)}{N}} \right)$$



Before applying the CLT, make sure that:  $\min\{Np_f; N(1-p_f)\} \ge 10$ 

Then,  $(1 - \alpha)$ -confidence intervals can be estimated:

$$\hat{p}_{f,\text{MCS}} + \Phi^{-1}\left(\frac{\alpha}{2}\right) \sqrt{\frac{p_f\left(1 - p_f\right)}{N}} \leq p_f \leq \hat{p}_{f,\text{MCS}} + \Phi^{-1}\left(1 - \frac{\alpha}{2}\right) \sqrt{\frac{p_f\left(1 - p_f\right)}{N}}$$



If 
$$1 - \alpha = 95\%$$

$$\Phi^{-1}\left(\frac{\alpha}{2}\right) \approx -1,96, \qquad \Phi^{-1}\left(1 - \frac{\alpha}{2}\right) \approx 1,96$$

## Brute-force Monte Carlo estimation

#### Convergence

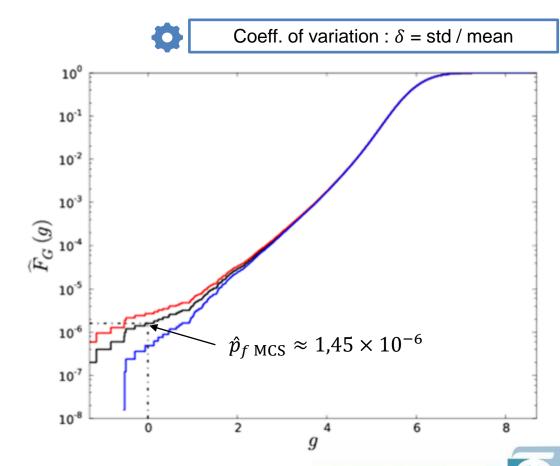
The required sample size drastically increases as the probability gets low.

Ex : For a given 10% target coefficient of variation of  $p_f$ 

$$\delta = \sqrt{\frac{1 - p_f}{N p_f}} \approx \frac{1}{\sqrt{N p_f}}$$

$$p_f \approx 10^{-k} \Rightarrow N_{\min} \approx 10^{k+2}$$

δ	$p_f$	N <sub>min</sub>
10%	$10^{-2}$	10 000
10%	$10^{-3}$	100 000
10%	$10^{-4}$	1 000 000



## Brute-force Monte Carlo estimation

Pros & consUnbiased, reference, estimator

Easy to implement Rich result (possible to build a good approximation of G's CDF)

Highly distributable over highperformance computing Slow convergence : requires important computing resources

#### When shoud it be used?

- You don't have cleverer choice
- The performance function is fast to evaluate :
  - Simple closed-form expressions;
  - HPC resources available.



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- Most-probable-failure-point(s)-based methods
  - Importance sampling  $\overline{\Phi}$
  - $\Phi$ Isoprobabilistic transformation
  - Some methods  $\overline{\Phi}$



## Most probable failure point(s)

#### Our goal

To estimate the probability of a failure (a rare event) efficiently

#### The idea

- Transformation of the problem by :
  - Identifying most probable failure cases;
  - Modifying the sampling method to get more failures in the dataset.

#### Solutions

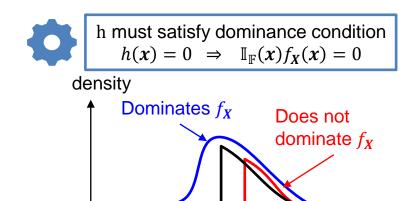
Importance sampling and isoprobabilistic transformations.



## Importance sampling

#### **Principle**

- We want to sample around critical events
- Let H denote some instrumental probability distribution with PDF h that would ideally make the failure event of interest more frequent.



The failure probability rewrites:

$$p_f = \int_{\mathbb{X}} \mathbb{I}_{\mathbb{F}}(x) f_X(x) dx = \int_{\mathbb{X}} \frac{\mathbb{I}_{\mathbb{F}}(x) f_X(x)}{h(x)} h(x) dx$$

$$p_f = \mathbb{E}_{\boldsymbol{Z}} \left[ \frac{\mathbb{I}_{\mathbb{F}}(\boldsymbol{Z}) f_{\boldsymbol{X}}(\boldsymbol{Z})}{h(\boldsymbol{Z})} \right]$$

## Importance sampling

#### Use & properties

• Given an *N*-sample:

$$\mathcal{Z} = \left\{ \mathbf{Z}^{(i)}, \quad i = 1, \dots, N \right\} \sim h$$

The importance sampling estimator reads:

$$\widehat{P}_{f,h} = \frac{1}{N} \sum_{i=1}^{N} \frac{\mathbb{I}_{\mathbb{F}}(\mathbf{Z}^{(i)}) f_{X}(\mathbf{Z}^{(i)})}{h(\mathbf{Z}^{(i)})}$$

and converges according to the CTL:

$$\hat{P}_{f,h} \underset{N \to \infty}{\sim} \mathcal{N}\left(p_f, \sigma_{p_f}\right)$$

The estimation variance obviously depends on h:

$$\sigma_{p_f}^2 = rac{1}{N} igg( \mathbb{E}_{m{Z}} \left[ rac{\mathbb{I}_{\mathbb{F}}(m{Z}) f_X^2(m{Z})}{h^2(m{Z})} 
ight] - p_f^2 igg)$$



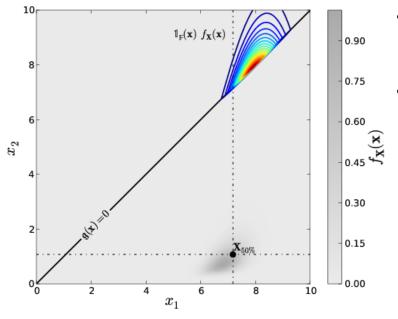
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## Importance sampling

#### Choosing h?

- Any distribution provided the dominance condition holds.
- The best instrumental PDF yields a zero estimation variance and reads:

$$h^*(x) = \frac{\mathbb{I}_{\mathbb{F}}(x)f_X(x)}{p_f}$$



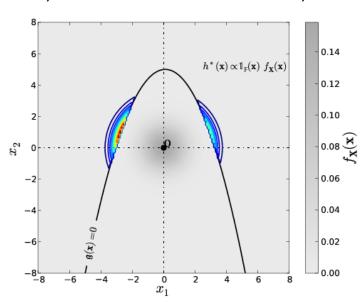
- Impractical : normalized by the sought probability  $p_f$ !
- confirms intuition:
  - it is the probability distribution of the input parameters yielding failure.
  - it barely satisfies the dominance condition.



## Importance sampling

#### A fundamental concept in reliability analysis

- The objective is to explore the tail of the safety margin's probability distribution (the lower tail in our case:  $p_f \equiv \text{Prob}[G \leq 0]$ )...
- Using a *biased sampling technique for the input* in order to make failure much more frequent...
- And ideally, by sampling only and exhaustively failed situations (i.e. without forgetting any (significant) area of the failure domain).





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  - Isoprobabilistic transformation
  - Some methods



#### Motivation

- G often follows a complex combination of heterogeneous marginals and copula, with no specific property.
- On the contrary, gaussian distribution is well-known and has good properties.
- Could we transform our composed distribution to a simpler one?

 $\Rightarrow$  isoprobabilistic transformation



#### **Principle**

- Transformation from physical space to standard space
- Conservation of probabilities

#### Available transformations

Type of copula	Transformation
Independent	Componentwise transformations
Elliptical	Generalized Nataf transformation
Any other	Rosenblatt transformation



The choice for the most-suitable transformation is automatic in OpenTURNS.



Further readings: Lebrun & Dutfoy (2009a,b,c)



### Standard space properties

- Given the components order of X and the Cholesky decomposition are fixed, the transformation is *unique* and *bijective* (it is *invertible*).
- The probability measure is preserved.



Does not hold for approximations

The transformed performance function is defined by composition:

$$g^{\circ}(\boldsymbol{u}) = g(\boldsymbol{x}) = (g \circ T^{-1})(\boldsymbol{u}), \qquad \boldsymbol{u} \in \mathbb{R}^n$$

Definition of the *failure domain* in the standard space:

$$\mathbb{F}^{\circ} = \{ \boldsymbol{u} \in \mathbb{R}^n : g^{\circ}(\boldsymbol{u}) \le 0 \}$$

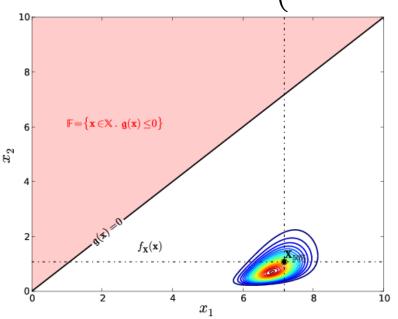


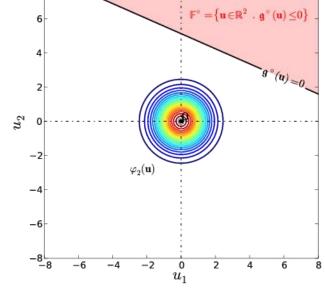
#### Standard space properties

• <u>Ex</u>: Resistance vs Stress model:

$$g(r,s) = r - s \text{ with } \begin{cases} R \sim \mathcal{LN}(\lambda_R, \zeta_R) \\ S \sim \mathcal{LN}(\lambda_S, \zeta_S) \end{cases}$$

$$Correlation \text{ by a normal copula } \rho_0 = 0,525$$





Physical space

Standard space



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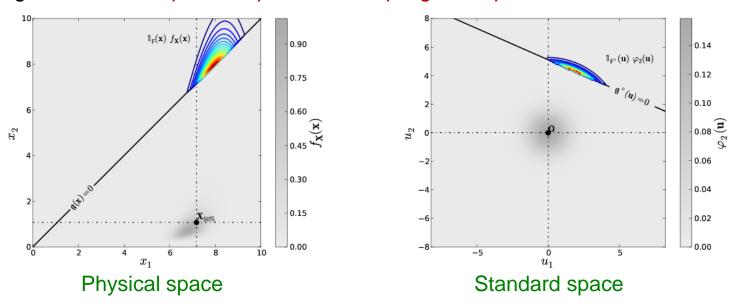


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## MPFP: FORM, SORM, P\*-IS & FORM- $\Sigma$

### Most probable failure point(s)

Let's get back to the *optimal importance sampling concept*:



We define the most probable failure point(s)  $u^*$  as the mode(s) of the optimal instrumental distribution:

$$u^* = \arg\max_{u \in \mathbb{R}^n} \mathbb{I}_{\mathbb{F}^{\circ}}(u) \varphi_n(u)$$

The solution is *not nessarily unique*, although it is often the case in many applications (e.g. in structural mechanics).

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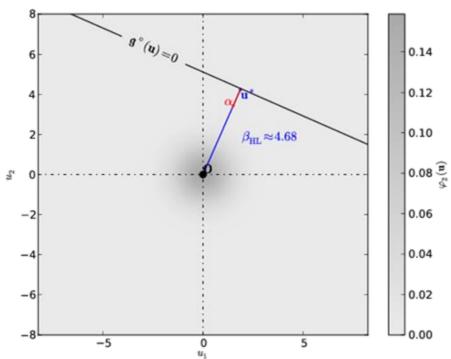
## MPFP: FORM, SORM, P\*-IS & FORM- $\Sigma$

### Most probable failure point(s)

Let's work on the definition:

$$\boldsymbol{u}^* = \arg\max_{\boldsymbol{u} \in \mathbb{R}^n} \mathbb{I}_{\mathbb{F}^\circ}(\boldsymbol{u}) \varphi_n(\boldsymbol{u}) = \arg\max_{\boldsymbol{u} \in \mathbb{R}^n} \tfrac{1}{(2\pi)^{n/2}} \exp\left(-\tfrac{1}{2}\boldsymbol{u}^\mathsf{T}\boldsymbol{u}\right) \colon g^\circ(\boldsymbol{u}) \leq 0$$

$$u^* = \arg\min_{u \in \mathbb{R}^n} u^T u$$
:  $g^{\circ}(u) \leq 0$ 



This is then equivalent to searching the *failure point(s)* in the standard space that are the closest to the origin.

### Search algorithms (constrained optimization)

- The *Abdo-Rackwitz algorithm* exploits the specificities of the problem at hand:
  - Quadratic objective function.
  - nonlinear constraint, but linearized at each step based on the information brought by the gradient.
  - The optimization steps (the moves amplitude) can either be *fixed* (small) or optimized (variable) using merit rules such as Goldstein-Armijo's.
  - The algorithm converges when the current point satisfies both:
    - $g(\mathbf{u}^*) = 0$  (the point in on the limit-state surface)
    - $\nabla_{\boldsymbol{u}} g^{\circ}(\boldsymbol{u}^{*}) / \boldsymbol{u}^{*}$  (the gradient of the constraint is colinear to that of the objective function)
- The COBYLA (Constrained Optimization BY Linear Approximations) algorithm is an interesting alternative when the partial differences of the performance function are hard to estimate (using finite differences schemes).

#### First-order reliability method (FORM)

- Assumption: the most probable failure point is *unique*.
- The performance function is linearized at the MPFP:

$$g_{1,\boldsymbol{u}^*}^{\circ}(\boldsymbol{u}) = g^{\circ}(\boldsymbol{u}^*) + \nabla_{\boldsymbol{u}}g^{\circ}(\boldsymbol{u}^*)^{\mathrm{T}}(\boldsymbol{u} - \boldsymbol{u}^*) = \nabla_{\boldsymbol{u}}g^{\circ}(\boldsymbol{u}^*)^{\mathrm{T}}(\boldsymbol{u} - \boldsymbol{u}^*)$$

We introduce the unit orientation vector

$$\alpha = \frac{\nabla_{\boldsymbol{u}} g^{\circ}(\boldsymbol{u}^{*})}{\|\nabla_{\boldsymbol{u}} g^{\circ}(\boldsymbol{u}^{*})\|_{2}}$$

And the *Hasofer-Lind reliability index*:

$$\beta_{\rm HL} = -\boldsymbol{\alpha}^{\rm T} \boldsymbol{u}^* = \overline{\rm OP}^*$$



#### First-order reliability method (FORM)

The approximate failure domain in the standard space rewrites:

$$\mathbb{F}_{1,u^*}^{\circ} = \left\{ \boldsymbol{u} \in \mathbb{R}^n : g_{1,u^*}^{\circ}(\boldsymbol{u}) \leq 0 \right\}$$

$$= \left\{ \boldsymbol{u} \in \mathbb{R}^n : \nabla_{\boldsymbol{u}} g^{\circ}(\boldsymbol{u}^*)^{\mathrm{T}}(\boldsymbol{u} - \boldsymbol{u}^*) \leq 0 \right\}$$

$$= \left\{ \boldsymbol{u} \in \mathbb{R}^n : \boldsymbol{\alpha}^{\mathrm{T}}(\boldsymbol{u} - \boldsymbol{u}^*) \leq 0 \right\}$$

$$= \left\{ \boldsymbol{u} \in \mathbb{R}^n : \boldsymbol{\alpha}^{\mathrm{T}} \boldsymbol{u} + \beta_{\mathrm{HL}} \leq 0 \right\}$$

So that we obtain the following first-order approximation of the failure probability:

$$p_{f 1, u^*} = \text{Prob}[\boldsymbol{\alpha}^{T} \boldsymbol{U} + \beta_{\text{HL}} \leq 0]$$
  
=  $\text{Prob}[Z \leq -\beta_{\text{HL}}]$ , with  $Z = \boldsymbol{\alpha}^{T} \boldsymbol{U} \sim \mathcal{N}(0, 1)$ 

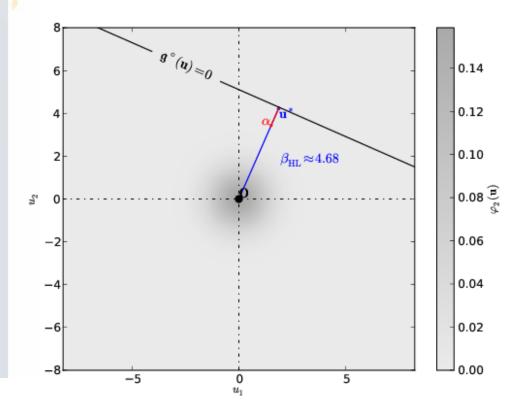
Hence:

$$p_{f 1, \boldsymbol{u}^*} = \Phi(-\beta_{\mathrm{HL}})$$



### First-order reliability method (FORM)

Ex: Resistance vs Stress model



$$\beta_{HL} \approx 4,68$$

$$p_{f 1,\boldsymbol{u}^*} \approx 1,44 \times 10^{-6}$$

- The limit-state surface being linear in the standard space, in this particular case, FORM is the reference solution.
- Generally speaking, this is only an approximation.

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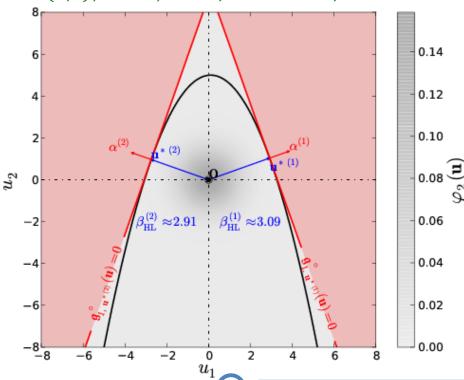
## MPFP: FORM, SORM, P\*-IS & FORM- $\Sigma$

### FORM: Multiple design points

<u>Ex</u>: Consider the following limit-state function:

$$g(x_1, x_2) = b - x_2 - \kappa (u_1 - e)^2$$

where  $X = U \sim \mathcal{N}(\mathbf{0}, \mathbf{I}), b = 5, \kappa = 0.5$  and e = 0.1.



See Der Kiureghian & Dakessian (1998).



#### SORM: accounting for local curvatures

Second-order Taylor approximation:

$$g_{2,\boldsymbol{u}^*}^{\circ} = g^{\circ}(\boldsymbol{u}^*) + \nabla_{\boldsymbol{u}}g^{\circ}(\boldsymbol{u}^*)^{\mathrm{T}}(\boldsymbol{u} - \boldsymbol{u}^*) + \frac{1}{2}(\boldsymbol{u} - \boldsymbol{u}^*)^{\mathrm{T}}\nabla_{\boldsymbol{u}\boldsymbol{u}}g^{\circ}(\boldsymbol{u}^*)(\boldsymbol{u} - \boldsymbol{u}^*)$$



Assuming  $\nabla_{uu}g^{\circ}(u^{*})$  is computable

For standard space spanned by Gaussian variables, *Breitung* has shown the following asymptotic result:

$$p_{f 2, \mathbf{u}^*} \underset{\beta_{\mathrm{HL}} \to +\infty}{\longrightarrow} \Phi(-\beta_{\mathrm{HL}}) \prod_{i=1}^{n} \frac{1}{\sqrt{1 + \beta_{\mathrm{HL}} \kappa_i}}$$

where  $\kappa_i$  are the *curvatures* calculated from the Hessian matrix (valid as soon as

$$1 + \beta_{HL} \kappa_i \ge 0$$
,  $i = 1, ..., n$ ).



Approx. Generalized by Lebrun & Dutfoy (2009a)



### P\*-IS: MPFP(s)-centered importance sampling

- Instrumental PDF centered at the identified MPFP(s).
- Gaussian instrumental distribution:

$$\varphi_{n,u^*}(u) = \varphi_n(u - u^*) = \frac{1}{(2\pi)^{n/2}} \exp\left(-\frac{(u - u^*)^{\mathrm{T}}(u - u^*)}{2}\right)$$

In this case, the failure probability *estimator* simplifies:

$$\widehat{P}_{f, \boldsymbol{u}^* \text{IS}} = \frac{\exp(-\beta_{\text{HL}}^2/2)}{N} \sum_{i=1}^{N} \mathbb{I}_{\mathbb{F}^{\circ}}(\boldsymbol{Z}^{(i)}) \exp(-\boldsymbol{Z}^{(i)} \boldsymbol{T} \boldsymbol{u}^*)$$

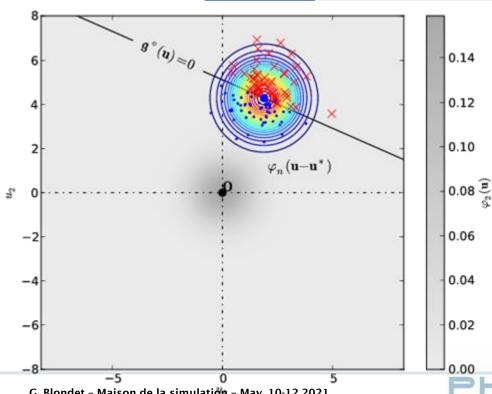
- Unbiased if unique MPFP (dominance condition of  $\varphi_{n,u^*}$  over  $\mathbb{I}_{\mathbb{F}^{\circ}} \times \varphi_n$ )
- Faster convergence: sampled points fails with a probability that is close to 50%.



## P\*-IS: MPFP(s)-centered importance sampling

Ex: Resistance vs Stress model

Monte Carlo	$10^8$ runs of g $\hat{p}_{f,  ext{MCS}} pprox 1,45  imes 10^{-6}$ up to a 10% coefficient of variation.
P*-IS	600 runs of g $p_{f, \pmb{u}^* \rm IS} \approx 1,\!49 \times 10^{-6}$ up to a 10% coefficient of variation.



#### FORM: importance factors

The unit direction vector indicates how the *reliability index evolves with respect to* the MPFP coordinates:

$$\beta_{\mathrm{HL}} = -\boldsymbol{\alpha}^{\mathrm{T}} \boldsymbol{u}^{*} = \sum_{i=1}^{n} -\alpha_{i} u_{i}^{*} \Rightarrow \alpha_{i} = -\frac{\partial \beta_{\mathrm{HL}}}{\partial u_{i}^{*}}$$

In case the distribution has a non-independent copula though, each standard variable  $u_i$  is a function of several original (physical) variable  $x_i$ , so that the  $\alpha_i$ 's are difficult to read.

#### FORM: importance factors

If copula is Normal, Lemaire (2009) defined the following corrected importance factors

$$\gamma_i = \frac{1}{\|\boldsymbol{\gamma}\|_2} \sigma_{X_i} \frac{\partial g}{\partial x_i} \bigg|_{\boldsymbol{x}=\boldsymbol{x}^*}, \qquad i=1,...,n$$

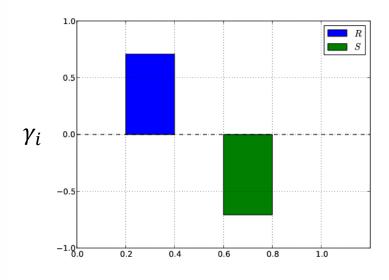
In the more general case, Lebrun & Dutfoy (2009c) proposed another more general, although unsigned, definition:

$$\gamma_i^2 = \frac{w_i^2}{\|\mathbf{w}\|_2^2}, \qquad i = 1, ..., n$$

$$\mathbf{w} = \begin{pmatrix} E^{-1} \left( F_{X_1}(x_1) \right) \\ \vdots \\ E^{-1} \left( F_{X_n}(x_n) \right) \end{pmatrix}$$

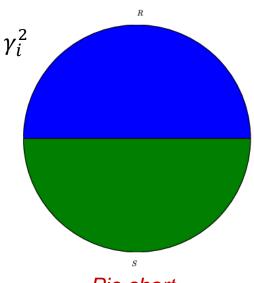
#### FORM: importance factors

These results are often presented in either one or both of these two charts:



Signed bar chart

 $\alpha_i$  or  $\gamma_i$  positive  $\Rightarrow X_i$  is a capacity variable  $\alpha_i$  of  $\gamma_i$  negative  $\Rightarrow X_i$  is a demand variable



Pie chart

The quadratic sum equals 1.

Qualitative comparison of the importance of variables w.r.t. failure.



#### FORM-Σ: Serial combination of linear limit-states

- Input: for the  $n_{P^*}$  identified MPFPs:
  - reliability indices:  $\boldsymbol{\beta}_{\mathrm{HL}} = \left(\beta_{\mathrm{HL}}^{(i)}, i = 1, ..., n_{P^*}\right)$
  - importance factors in the standard space:  $\mathbf{A} = (\boldsymbol{\alpha}^{(i)}, i = 1, ..., n_{P^*})$
- Objective: combine these results into a single probability, the one associated to the serial system formed by the contributors.
- Solution:

$$\left[ p_{f,1\Sigma} = \operatorname{Prob} \left[ \boldsymbol{U} \in \bigcup_{i=1}^{n_{P^*}} \left\{ \boldsymbol{u} \in \mathbb{R}^n : \boldsymbol{\alpha}^{(i)} \, ^{\mathrm{T}} \boldsymbol{u} + \beta_{\mathrm{HL}}^{(i)} \leq 0 \right\} \right] = 1 - \Phi_{n_{P^*}}(\boldsymbol{\beta}_{\mathrm{HL}}; \boldsymbol{0}, \boldsymbol{\rho})$$

where:

$$\rho_{ij} = \boldsymbol{\alpha}^{(i) \mathrm{T}} \boldsymbol{\alpha}^{(j)}, \qquad i, j = 1, ..., n_{P^*}$$

are the « pairwise limit-states' correlation »  $(-1 \le \rho \le 1)$ .

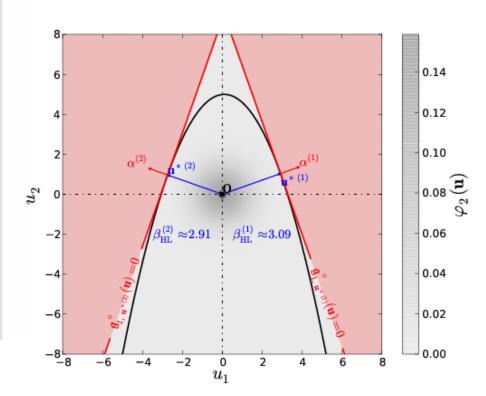


#### FORM-Σ: Serial combination of linear limit-states

Ex : Consider the following limit-state function:

$$g(x_1, x_2) = b - x_2 - \kappa (u_1 - e)^2$$

where  $X = U \sim \mathcal{N}(\mathbf{0}, \mathbf{I}), b = 5, \kappa = 0.5$  and e = 0.1.



The correlation between the two limitstates is:

$$\rho_{12} = \boldsymbol{\alpha}^{(1) \, \mathrm{T}} \boldsymbol{\alpha}^{(2)} \approx -0.78$$

Hence the *first-order approximation* of the serial system failure probability is:

$$p_{f1,\Sigma} = 1 - \Phi_2 \left( \begin{pmatrix} 3,09 \\ 2,91 \end{pmatrix}; 0, \begin{bmatrix} 1 & -0,78 \\ -0,78 & 1 \end{bmatrix} \right)$$
  

$$\approx 2,82 \times 10^{-3}$$

The crude Monte Carlo estimate is:

$$\hat{p}_{f,MCS} \approx 3.12 \times 10^{-3}$$

Up to a 10% coefficient of variation.



#### Pros & Cons

Coordinates: singular configuration(s) of the system.

Importance factors: clues for improving reliability.

Affordable computational cost.

non-unicity risk (FORM, SORM & basic P\*-IS)

non-completeness risk (FORM- $\Sigma$ )

Missing (FORM, SORM, FORM- $\Sigma$ ) or subjective (P\*-IS) error metric

#### When should it be used?

- As a first *approximation*;
- Confirmed by an expert judgement about the identified failure modes.



## Conclusions

Reliability methods aim at estimating the safety level attached to a component in the form of a *subjective failure probability*:

$$p_f = \text{Prob}[\text{failure} \mid \text{model}]$$

- Crude Monte Carlo sampling
  - Model exploration, no assumption, expensive.
- Most-probable-failure-point(s)-based techniques
  - cheaper (even if HPC may still help) but assumptions and approximations.
  - deeper investigation of the system (MPFP coordinates, importance factors).

## Further readings

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